IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION

Thorsten Lower

OF:

CASE:

OST-031107

RESPONSE TO

OFFICE ACTION

SER. NO.:

10/619,933

FILING DATE:

July 15, 2003

FOR:

METHOD FOR MEASURING THE INTENSITY

PROFILE OF AN ELECTRON BEAM, IN PARTICLAR A BEAM OF AN ELECTRON-

BEAM MACHINING DEVICE...

Mail Stop: Amendment

COMMISSIONER FOR PATENTS

P.O. Box 1450

Alexandria, VA 22313-1450

Examiner:

J. J. LEYBOURNE

Art Unit

2881

Dear Examiner:

If any charges or fees must be paid in connection with the following communication, they may be paid out of our Deposit Account No. 50-0545.

In response to the Office Action of November 01, 2004, please amend the aboveidentified application as follows:

Amendments to the Claims are reflected in the listing of claims that begins on page 2 of this paper.

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01 FC:2202 625.00 0P

01 EC:2202

625-00=0P

Jody L. Factor
Micheal D. Lake
33727
Edward L. Bishop
William J. Lenz
Joseph M. Kinsella Jr.
Jacob D. Koering
Nick S. Lee
34157
34157
34208
34157
34208
35110
35110
35110
35110

FACTOR & LAKE, LTD. 1327 W. Washington Blvd. Suite 5G/H Chicago, Illinois 60607 Tel: (312) 226-1818 Fax: (312) 226-1919